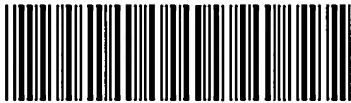


Search Notes

Application/Control No.

10/626,167

Examiner

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Applicant(s)/Patent under
Reexamination

KLEIN ET AL.

Art Unit

3753

SEARCHED

Class	Subclass	Date	Examiner
UPDATED	SEARCH	12/8/2005	KL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
INTERFERENCE search (US-PGPUB)	12/8/2005	KL